

## An Approach to Increase Density of Field-Effect Heterotransistors Framework Circuits NAND and AND

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### Abstract

We introduce an approach to increase density of field effect heterotransistors, which include into itself circuits NAND and AND. The approach based on manufacturing a specific configuration of a heterostructure. After the manufacturing, we consider doping of several areas of the heterostructure by diffusion or ion implantation. After the doping, we consider optimized annealing of dopants and generated radiation defects during ion implantation. We consider redistribution of dopant and radiation defects under influence of mismatch induced stress. Some comparison of calculated results with experimental one has been done.

**Keywords:** *Circuits NAND and AND; increasing of density of elements*

### Introduction

Currently density of elements of integrated circuits is intensively increasing. To obtain the increasing dimensions of the elements should decreased. Presently several methods to decrease the dimensions have been developed. One way to decrease the dimensions is growing thin films structures and manufacturing the above elements framework the structures [1-5]. Another one is using laser or microwave irradiation to anneal dopants or radiation defects [6-9]. Both types of annealing lead to generation in homogenous distribution of temperature. In this situation one can obtain more in homogenous distribution of dopant and consequently more compact elements framework the considered integrated circuits. Another approach to change properties of doped materials is radiation processing [10,11].

Framework the present paper we consider an approach to manufacture smaller field-effect heterotransistors framework circuits NAND and AND. We assume that the considered transistors have been manufactured framework a heterostructure. The heterostructure consist of a substrate and an epitaxial layer. We consider several sections, which were manufactured in the epitaxial layer by using other materials. After that we consider diffusion and ion types of doping to prepare p or n types of conductivity in the considered sections. Now we consider manufacturing a field effect transistors framework the heterostructure with epitaxial layer on FIG. 1. Now we consider annealing of dopant (for diffusion type of doping) and radiation defects (for ion type of doping).

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Main aim of the present paper is optimization of the annealing. The optimization gives a possibility to obtain increasing of density of transistors in these circuits with decreasing their dimensions. We also consider an approach of decreasing of mismatch- induced stress in heterostructure.

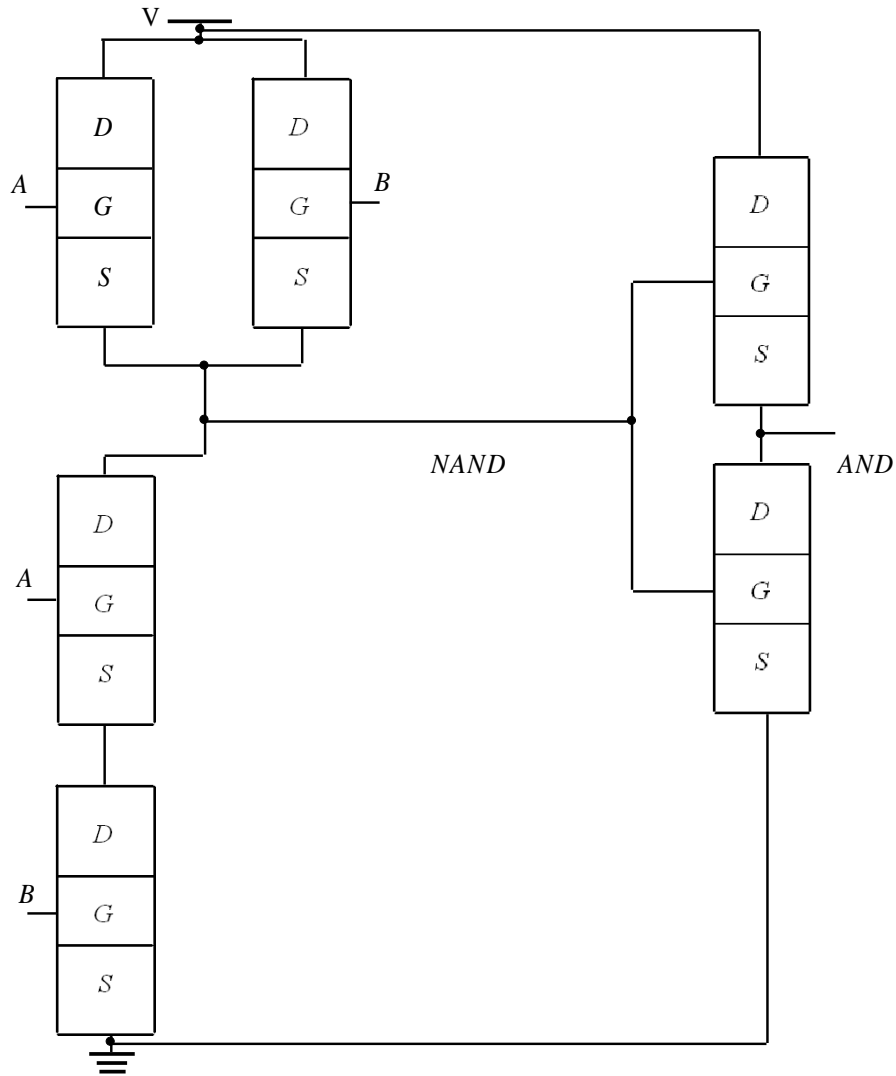


FIG. 1. Structure of circuits NAND and AND. View from top.

**Method of solution**

To solve our aim, we calculate spatio temporal distribution of concentration of dopant. We consider the distribution as solution of the following boundary problem [10-14].

$$\frac{\partial C(x, y, z, t)}{\partial t} = \frac{\partial}{\partial x} \left[ D \frac{\partial C(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ D \frac{\partial C(x, y, z, t)}{\partial y} \right] + \frac{\partial}{\partial z} \left[ D \frac{\partial C(x, y, z, t)}{\partial z} \right] + \quad (1)$$

$$+ \Omega \frac{\partial}{\partial x} \left[ \frac{D_s}{kT} \nabla_s \mu (x, y, z, t) \int_0^{L_z} C(x, y, W, t) dW \right] + \Omega \frac{\partial}{\partial y} \left[ \frac{D_s}{kT} \nabla_s \mu (x, y, z, t) \int_0^{L_z} C(x, y, W, t) dW \right]$$

with boundary and initial conditions

$$\begin{aligned} \left. \frac{\partial C(x, y, z, t)}{\partial x} \right|_{x=0} = 0, \quad \left. \frac{\partial C(x, y, z, t)}{\partial x} \right|_{x=L_x} = 0, \quad \left. \frac{\partial C(x, y, z, t)}{\partial y} \right|_{y=0} = 0, \quad \left. \frac{\partial C(x, y, z, t)}{\partial y} \right|_{y=L_y} = 0 \\ \left. \frac{\partial C(x, y, z, t)}{\partial z} \right|_{z=0} = 0, \quad \left. \frac{\partial C(x, y, z, t)}{\partial z} \right|_{z=L_z} = 0, \quad C(x, y, z, 0) = f_C(x, y, z). \end{aligned}$$

Here  $C(x, y, z, t)$  is the spatio temporal distribution of concentration of dopant;  $\Omega$  is the atomic volume of the dopant; symbol  $\Omega S$  is the surficial gradient;  $\int_0^{L_z} C(x, y, z, t) dz$  is the surficial concentration of dopant in neighborhood of the interface between materials of heterostructure (in this case we assume, that Z-axis is perpendicular to the interface between materials of heterostructure);  $\mu(x, y, z, t)$  is the chemical potential;  $D$  and  $D_s$  are the coefficients of volumetric and surficial diffusions (the surficial diffusion is the consequences of mismatch-induced stress). Values of diffusion coefficients depend on properties of materials of heterostructure, speed of heating and cooling of heterostructure, concentration of dopant. Dependences of dopant diffusion coefficients on parameters could be approximated by the following relations [12].

$$\begin{aligned} D_C = D_L(x, y, z, T) \left[ 1 + \xi \frac{C^\gamma(x, y, z, t)}{P^\gamma(x, y, z, T)} \right] \left[ 1 + \zeta_1 \frac{V(x, y, z, t)}{V^*} + \zeta_2 \frac{V^2(x, y, z, t)}{(V^*)^2} \right] \\ D_S = D_{SL}(x, y, z, T) \left[ 1 + \xi_s \frac{C^\gamma(x, y, z, t)}{P^\gamma(x, y, z, T)} \right] \left[ 1 + \zeta_1 \frac{V(x, y, z, t)}{V^*} + \zeta_2 \frac{V^2(x, y, z, t)}{(V^*)^2} \right] \quad (2) \end{aligned}$$

Here  $D_L(x, y, z, T)$  and  $D_{LS}(x, y, z, T)$  are the spatial (due to accounting all layers of hetero-structure) and temperature (due to Arrhenius law) dependences of dopant diffusion coefficients;  $T$  is the temperature of annealing;  $P(x, y, z, T)$  is the limit of solubility of dopant; parameter  $\gamma$  depends on properties of materials and could be integer in the following interval  $\gamma \in [1, 3]$  [12],  $V(x, y, z, t)$  is the spatio-temporal distribution of concentration of radiation vacancies;  $V^*$  is the equilibrium distribution of vacancies. Concentration dependence of dopant diffusion coefficient has been described in details in [12] ref. Spatio temporal distributions of concentration of point radiation defects have been determined by solving the following system of equations [11,13,14].

$$\begin{aligned} \frac{\partial I(x, y, z, t)}{\partial t} = \frac{\partial}{\partial x} \left[ D_I(x, y, z, T) \frac{\partial I(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ D_I(x, y, z, T) \frac{\partial I(x, y, z, t)}{\partial y} \right] + \\ + \frac{\partial}{\partial z} \left[ D_I(x, y, z, T) \frac{\partial I(x, y, z, t)}{\partial z} \right] - k_{I,I}(x, y, z, T) I^2(x, y, z, t) - k_{I,V}(x, y, z, T) I(x, y, z, t) \times \\ \times V(x, y, z, t) + \Omega \frac{\partial}{\partial x} \left[ \frac{D_{IS}}{kT} \nabla_s \mu(x, y, z, t) \int_0^{L_z} I(x, y, W, t) dW \right] + \end{aligned}$$

$$\begin{aligned}
 & +\Omega \frac{\partial}{\partial y} \left[ \frac{D_{IS}}{kT} \nabla_s \mu (x, y, z, t) \int_0^{L_z} I(x, y, W, t) dW \right] \quad (3) \\
 \frac{\partial V(x, y, z, t)}{\partial t} & = \frac{\partial}{\partial x} \left[ D_V(x, y, z, T) \frac{\partial V(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ D_V(x, y, z, T) \frac{\partial V(x, y, z, t)}{\partial y} \right] + \\
 & + \frac{\partial}{\partial z} \left[ D_V(x, y, z, T) \frac{\partial V(x, y, z, t)}{\partial z} \right] - k_{V,V}(x, y, z, T) V^2(x, y, z, t) - k_{I,V}(x, y, z, T) I(x, y, z, t) \times \\
 & \times V(x, y, z, t) + \Omega \frac{\partial}{\partial x} \left[ \frac{D_{VS}}{kT} \nabla_s \mu (x, y, z, t) \int_0^{L_z} V(x, y, W, t) dW \right] + \\
 & + \Omega \frac{\partial}{\partial y} \left[ \frac{D_{VS}}{kT} \nabla_s \mu (x, y, z, t) \int_0^{L_z} V(x, y, W, t) dW \right]
 \end{aligned}$$

with boundary and initial conditions

$$\begin{aligned}
 \left. \frac{\partial I(x, y, z, t)}{\partial x} \right|_{x=0} & = 0 \quad \left. \frac{\partial I(x, y, z, t)}{\partial x} \right|_{x=L_x} = 0 \quad \left. \frac{\partial I(x, y, z, t)}{\partial y} \right|_{y=0} = 0 \quad \left. \frac{\partial I(x, y, z, t)}{\partial y} \right|_{y=L_y} = 0 \\
 \left. \frac{\partial I(x, y, z, t)}{\partial z} \right|_{z=0} & = 0 \quad \left. \frac{\partial I(x, y, z, t)}{\partial z} \right|_{z=L_z} = 0 \quad \left. \frac{\partial V(x, y, z, t)}{\partial x} \right|_{x=0} = 0 \quad \left. \frac{\partial V(x, y, z, t)}{\partial x} \right|_{x=L_x} = 0 \\
 \left. \frac{\partial V(x, y, z, t)}{\partial y} \right|_{y=0} & = 0 \quad \left. \frac{\partial V(x, y, z, t)}{\partial y} \right|_{y=L_y} = 0 \quad \left. \frac{\partial V(x, y, z, t)}{\partial z} \right|_{z=0} = 0 \quad \left. \frac{\partial V(x, y, z, t)}{\partial z} \right|_{z=L_z} = 0 \\
 I(x, y, z, 0) & = f_I(x, y, z), \quad V(x, y, z, 0) = f_V(x, y, z). \quad (4)
 \end{aligned}$$

Here  $I(x, y, z, t)$  is the spatio-temporal distribution of concentration of radiation interstitials;  $I^*$  is the equilibrium distribution of interstitials;  $D_I(x, y, z, T)$ ,  $D_V(x, y, z, T)$ ,  $D_{IS}(x, y, z, T)$ ,  $D_{VS}(x, y, z, T)$  are the coefficients of volumetric and surficial diffusions of interstitials and vacancies, respectively; terms  $V^2(x, y, z, t)$  and  $I^2(x, y, z, t)$  correspond to generation of divacancies and diinterstitials, respectively [11],  $k_{I,V}(x, y, z, T)$ ,  $k_{I,I}(x, y, z, T)$  and  $k_{V,V}(x, y, z, T)$  are the parameters of recombination of point radiation defects and generation of their complexes.

We determine spatio-temporal distributions of concentrations of divacancies  $\Phi_V(x, y, z, t)$  and diinterstitials  $\Phi_I(x, y, z, t)$  by solving the following system of equations [11,13,14].

$$\frac{\partial \Phi_I(x, y, z, t)}{\partial t} = \frac{\partial}{\partial x} \left[ D_{\Phi_I}(x, y, z, T) \frac{\partial \Phi_I(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ D_{\Phi_I}(x, y, z, T) \frac{\partial \Phi_I(x, y, z, t)}{\partial y} \right] +$$

$$\begin{aligned}
 & + \frac{\partial}{\partial z} \left[ D_{\Phi_I} (x, y, z, T) \frac{\partial \Phi_I (x, y, z, t)}{\partial z} \right] + \Omega \frac{\partial}{\partial x} \left[ \frac{D_{\Phi_I S}}{kT} \nabla_S \mu (x, y, z, t) \int_0^{L_z} \Phi_I (x, y, W, t) dW \right] + \\
 & + \Omega \frac{\partial}{\partial y} \left[ \frac{D_{\Phi_I S}}{kT} \nabla_S \mu (x, y, z, t) \int_0^{L_z} \Phi_I (x, y, W, t) dW \right] + k_{I,I} (x, y, z, T) I^2 (x, y, z, t) + \\
 & + k_I (x, y, z, T) I (x, y, z, t) \quad (5) \\
 & + \frac{\partial}{\partial z} \left[ D_{\Phi_V} (x, y, z, T) \frac{\partial \Phi_V (x, y, z, t)}{\partial z} \right] + \Omega \frac{\partial}{\partial x} \left[ \frac{D_{\Phi_V S}}{kT} \nabla_S \mu (x, y, z, t) \int_0^{L_z} \Phi_V (x, y, W, t) dW \right] + \\
 & \frac{\partial \Phi_V (x, y, z, t)}{\partial t} = \frac{\partial}{\partial x} \left[ D_{\Phi_V} (x, y, z, T) \frac{\partial \Phi_V (x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ D_{\Phi_V} (x, y, z, T) \frac{\partial \Phi_V (x, y, z, t)}{\partial y} \right] + \\
 & + \Omega \frac{\partial}{\partial y} \left[ \frac{D_{\Phi_V S}}{kT} \nabla_S \mu (x, y, z, t) \int_0^{L_z} \Phi_V (x, y, W, t) dW \right] + k_{V,V} (x, y, z, T) V^2 (x, y, z, t) + \\
 & + k_V (x, y, z, T) V (x, y, z, t)
 \end{aligned}$$

with boundary and initial conditions

$$\begin{aligned}
 \left. \frac{\partial \Phi_I (x, y, z, t)}{\partial x} \right|_{x=0} &= 0 \quad \left. \frac{\partial I (x, y, z, t)}{\partial x} \right|_{x=L_x} = 0 \quad \left. \frac{\partial I (x, y, z, t)}{\partial y} \right|_{y=0} = 0 \quad \left. \frac{\partial I (x, y, z, t)}{\partial y} \right|_{y=L_y} = 0 \\
 \left. \frac{\partial \Phi_I (x, y, z, t)}{\partial z} \right|_{z=0} &= 0 \quad \left. \frac{\partial I (x, y, z, t)}{\partial z} \right|_{z=L_z} = 0 \quad \left. \frac{\partial \Phi_V (x, y, z, t)}{\partial x} \right|_{x=0} = 0 \quad \left. \frac{\partial V (x, y, z, t)}{\partial x} \right|_{x=L_x} = 0 \\
 \left. \frac{\partial V (x, y, z, t)}{\partial y} \right|_{y=0} &= 0 \quad \left. \frac{\partial V (x, y, z, t)}{\partial y} \right|_{y=L_y} = 0 \quad \left. \frac{\partial V (x, y, z, t)}{\partial z} \right|_{z=0} = 0 \quad \left. \frac{\partial \Phi_V (x, y, z, t)}{\partial z} \right|_{z=L_z} = 0 \\
 \Phi_I (x, y, z, 0) &= f \Phi_I (x, y, z), \quad \Phi_V (x, y, z, 0) = f \Phi_V (x, y, z). \quad (6)
 \end{aligned}$$

Here  $D\Phi_I (x, y, z, T)$ ,  $D\Phi_V (x, y, z, T)$ ,  $D\Phi_{IS} (x, y, z, T)$  and  $D\Phi_{VS} (x, y, z, T)$  are the coefficients of volumetric and surficial diffusions of complexes of radiation defects  $k_I (x, y, z, T)$  and  $k_V (x, y, z, T)$  are the parameters of decay of these complexes. Chemical potential in Eq (1) could be determined by the following relation [13]

$$m = E(z) W s_{ij} [u_{ij} (x, y, z, t) + u_{ji} (x, y, z, t)] / 2, \quad (7)$$

where  $E (z, C) = E1 (z) + E2 (z) [C(x, y, z, t)/P(x,y,z,T)]$  [15] is the Young modulus,  $\sigma_{ij}$  is the stress tensor;

$u_{ij} = \frac{1}{2} \left( \frac{\partial u_i}{\partial x_j} + \frac{\partial u_j}{\partial x_i} \right)$  is the deformation tensor;  $u_i, u_j$  are the components  $u_x (x, y, z, t)$ ,  $u_y (x, y, z, t)$  and  $u_z (x, y, z, t)$  of the displacement vector ; variables  $x_i, x_j$  equal to  $x, y, z$  depends on number of equation for components of displacement vector.

The Eq. (7) could be transformed to the following form

$$\mu(x, y, z, t) = \left[ \frac{\partial u_i(x, y, z, t)}{\partial x_j} + \frac{\partial u_j(x, y, z, t)}{\partial x_i} \right] \left\{ \frac{1}{2} \left[ \frac{\partial u_i(x, y, z, t)}{\partial x_j} + \frac{\partial u_j(x, y, z, t)}{\partial x_i} \right] - \varepsilon_0 \delta_{ij} + \frac{\sigma(z) \delta_{ij}}{1 - 2\sigma(z)} \left[ \frac{\partial u_k(x, y, z, t)}{\partial x_k} - 3\varepsilon_0 \right] - K(z) \beta(z) [T(x, y, z, t) - T_0] \delta_{ij} \right\} \frac{\Omega}{2} E(z, C)$$

Where  $\sigma$  is the Poisson coefficient;  $\varepsilon_0 = (a_s - a_{EL})/a_{EL}$  is the mismatch parameter;  $a_s, a_{EL}$  are the lattice distances of the substrate and the epitaxial layer, respectively;  $K$  is the modulus of uniform compression;  $\beta$  is the coefficient of thermal expansion;  $T_r$  is the equilibrium temperature which coincides (for our case) with the room temperature. Components of displacement vector could be obtained by solution of the following equations [15,16]

$$\begin{cases} \rho(z) \frac{\partial^2 u_x(x, y, z, t)}{\partial t^2} = \frac{\partial \sigma_{xx}(x, y, z, t)}{\partial x} + \frac{\partial \sigma_{xy}(x, y, z, t)}{\partial y} + \frac{\partial \sigma_{xz}(x, y, z, t)}{\partial z} \\ \rho(z) \frac{\partial^2 u_y(x, y, z, t)}{\partial t^2} = \frac{\partial \sigma_{yx}(x, y, z, t)}{\partial x} + \frac{\partial \sigma_{yy}(x, y, z, t)}{\partial y} + \frac{\partial \sigma_{yz}(x, y, z, t)}{\partial z} \\ \rho(z) \frac{\partial^2 u_z(x, y, z, t)}{\partial t^2} = \frac{\partial \sigma_{zx}(x, y, z, t)}{\partial x} + \frac{\partial \sigma_{zy}(x, y, z, t)}{\partial y} + \frac{\partial \sigma_{zz}(x, y, z, t)}{\partial z} \end{cases}$$

Here

$$\sigma_{ij} = \frac{E(z)}{2[1 + \sigma(z)]} \left[ \frac{\partial u_i(x, y, z, t)}{\partial x_j} + \frac{\partial u_j(x, y, z, t)}{\partial x_i} - \frac{\delta_{ij}}{3} \frac{\partial u_k(x, y, z, t)}{\partial x_k} \right] + \delta_{ij} \frac{\partial u_k(x, y, z, t)}{\partial x_k} \times K(z) - \beta(z) K(z) [T(x, y, z, t) - T_r]$$

$\rho(z)$  is the density of materials of heterostructure,  $\delta_{ij}$  is the Kronecker symbol.

Accounting the above relation for  $\sigma_{ij}$  in the previous system of equations last system of equation could be written as

$$\begin{aligned} \rho(z) \frac{\partial^2 u_x(x, y, z, t)}{\partial t^2} &= \left\{ K(z) + \frac{5E(z, C)}{6[1 + \sigma(z)]} \right\} \frac{\partial^2 u_x(x, y, z, t)}{\partial x^2} + \left\{ K(z) - \frac{E(z, C)}{3[1 + \sigma(z)]} \right\} \times \\ &\times \frac{\partial^2 u_y(x, y, z, t)}{\partial x \partial y} + \frac{E(z, C)}{2[1 + \sigma(z)]} \left[ \frac{\partial^2 u_y(x, y, z, t)}{\partial y^2} + \frac{\partial^2 u_z(x, y, z, t)}{\partial z^2} \right] + \left[ K(z) + \frac{E(z, C)}{3[1 + \sigma(z)]} \right] \times \\ &\times \frac{\partial^2 u_z(x, y, z, t)}{\partial x \partial z} - K(z) \beta(z) \frac{\partial T(x, y, z, t)}{\partial x} \\ \rho(z) \frac{\partial^2 u_y(x, y, z, t)}{\partial t^2} &= \frac{E(z, C)}{2[1 + \sigma(z)]} \left[ \frac{\partial^2 u_y(x, y, z, t)}{\partial x^2} + \frac{\partial^2 u_x(x, y, z, t)}{\partial x \partial y} \right] - \frac{\partial T(x, y, z, t)}{\partial y} \times \\ &\times K(z) \beta(z) + \frac{\partial}{\partial z} \left\{ \frac{E(z, C)}{2[1 + \sigma(z)]} \left[ \frac{\partial u_y(x, y, z, t)}{\partial z} + \frac{\partial u_z(x, y, z, t)}{\partial y} \right] \right\} + \frac{\partial^2 u_y(x, y, z, t)}{\partial y^2} \times \end{aligned}$$

$$\begin{aligned} & \times \left\{ \frac{5E(z, C)}{12[1+\sigma(z)]} + K(z) \right\} + \left\{ K(z) - \frac{E(z, C)}{6[1+\sigma(z)]} \right\} \frac{\partial^2 u_y(x, y, z, t)}{\partial y \partial z} + K(z) \frac{\partial^2 u_y(x, y, z, t)}{\partial x \partial y} \\ & \rho(z) \frac{\partial^2 u_z(x, y, z, t)}{\partial t^2} = \frac{E(z, C)}{2[1+\sigma(z)]} \left[ \frac{\partial^2 u_z(x, y, z, t)}{\partial x^2} + \frac{\partial^2 u_z(x, y, z, t)}{\partial y^2} + \frac{\partial^2 u_x(x, y, z, t)}{\partial x \partial z} + \right. \\ & \left. + \frac{\partial^2 u_y(x, y, z, t)}{\partial y \partial z} \right] + \frac{\partial}{\partial z} \left\{ K(z) \left[ \frac{\partial u_x(x, y, z, t)}{\partial x} + \frac{\partial u_y(x, y, z, t)}{\partial y} + \frac{\partial u_x(x, y, z, t)}{\partial z} \right] \right\} + \\ & \left. + \frac{1}{6} \frac{\partial}{\partial z} \left\{ \frac{E(z, C)}{1+\sigma(z)} \left[ 6 \frac{\partial u_z(x, y, z, t)}{\partial z} - \frac{\partial u_x(x, y, z, t)}{\partial x} - \frac{\partial u_y(x, y, z, t)}{\partial y} - \frac{\partial u_z(x, y, z, t)}{\partial z} \right] \right\} \right\} - \\ & -K(z) \beta(z) \frac{\partial T(x, y, z, t)}{\partial z} \end{aligned}$$

Conditions for the system of these equations are

$$\begin{aligned} \left. \frac{\partial \bar{u}(x, y, z, t)}{\partial x} \right|_{x=0} = 0 \quad \left. \frac{\partial \bar{u}(x, y, z, t)}{\partial x} \right|_{x=L_x} = 0 \quad \left. \frac{\partial \bar{u}(x, y, z, t)}{\partial y} \right|_{y=0} = 0 \quad \left. \frac{\partial \bar{u}(x, y, z, t)}{\partial y} \right|_{y=L_y} = 0 \\ \left. \frac{\partial \bar{u}(x, y, z, t)}{\partial z} \right|_{z=0} = 0 \quad \left. \frac{\partial \bar{u}(x, y, z, t)}{\partial z} \right|_{z=L_z} = 0 \quad \bar{u}(x, y, z, 0) = \bar{u}_0 \quad \bar{u}(x, y, z, \infty) = \bar{u}_0 \end{aligned}$$

We determine spatio-temporal distributions of concentrations of dopant and radiation defects by solving the Eqs. (1), (3) and (5) simultaneously by the standard method of averaging of function corrections [17,18]. On the first step of solving of our aim we take into account initial distributions of the considered concentrations in the Eqs. (1), (3) and (5). In this situation initial conditions after appropriate equations will be equal to zero. After that we replace the required functions in right sides of Eqs. (1a), (3a) and (5a) on their not yet known average values  $\alpha_i \rho$ . In this situation, we obtain equations for the first-order approximations of the considered concentrations in the following form

$$\begin{aligned} \frac{\partial C_1(x, y, z, t)}{\partial t} = \alpha_{1c} \Omega \frac{\partial}{\partial x} \left[ z \frac{D_s}{kT} \nabla_s \mu(x, y, z, t) \right] + \alpha_{1c} \Omega \frac{\partial}{\partial y} \left[ z \frac{D_s}{kT} \nabla_s \mu(x, y, z, t) \right] + \\ + f_c(x, y, z) \delta(t) \end{aligned} \tag{1b}$$

$$\begin{aligned} \frac{\partial I_1(x, y, z, t)}{\partial t} = f_I(x, y, z) \delta(t) + \alpha_{1I} z \Omega \frac{\partial}{\partial x} \left[ \frac{D_{IS}}{kT} \nabla_s \mu(x, y, z, t) \right] + \\ + \alpha_{1I} \Omega \frac{\partial}{\partial y} \left[ z \frac{D_{IS}}{kT} \nabla_s \mu(x, y, z, t) \right] - \alpha_{1I}^2 k_{I,I}(x, y, z, T) - \alpha_{1I} \alpha_{1V} k_{I,V}(x, y, z, T) \end{aligned} \tag{3b}$$

$$\frac{\partial V_1(x, y, z, t)}{\partial t} = f_V(x, y, z) \delta(t) + \alpha_{1V} z \Omega \frac{\partial}{\partial x} \left[ \frac{D_{VS}}{kT} \nabla_s \mu(x, y, z, t) \right] +$$

$$\begin{aligned}
 & +\alpha_{IV}\Omega\frac{\partial}{\partial y}\left[z\frac{D_{VS}}{kT}\nabla_S\mu(x,y,z,t)\right]-\alpha_{IV}^2k_{V,V}(x,y,z,T)-\alpha_{IV}\alpha_{IV}k_{I,V}(x,y,z,T) \\
 & \frac{\partial\Phi_{II}(x,y,z,t)}{\partial t}=f_{\Phi_I}(x,y,z)\delta(t)+\alpha_{I\Phi_I}z\Omega\frac{\partial}{\partial x}\left[\frac{D_{\Phi_I S}}{kT}\nabla_S\mu(x,y,z,t)\right]+ \\
 & +\alpha_{I\Phi_I}z\Omega\frac{\partial}{\partial y}\left[\frac{D_{\Phi_I S}}{kT}\nabla_S\mu(x,y,z,t)\right]+k_{I,I}(x,y,z,T)I^2(x,y,z,t)+k_I(x,y,z,T)I(x,y,z,t) \\
 & \frac{\partial\Phi_{IV}(x,y,z,t)}{\partial t}=f_{\Phi_V}(x,y,z)\delta(t)+\alpha_{I\Phi_V}z\Omega\frac{\partial}{\partial x}\left[\frac{D_{\Phi_V S}}{kT}\nabla_S\mu(x,y,z,t)\right]+ \\
 & +\alpha_{I\Phi_V}z\Omega\frac{\partial}{\partial y}\left[\frac{D_{\Phi_V S}}{kT}\nabla_S\mu(x,y,z,t)\right]+k_{V,V}(x,y,z,T)V^2(x,y,z,t)+k_V(x,y,z,T)V(x,y,z,t)
 \end{aligned}$$

Integration of the left and right sides of Eqs. (1b), (3b) and (5b) gives us the possibility to obtain relations for above first-order approximations in the following form

$$\begin{aligned}
 C_1(x,y,z,t) & =\alpha_{IC}\Omega\frac{\partial}{\partial x}\int_0^t D_{SL}(x,y,z,T)\nabla_S\mu(x,y,z,\tau)\left[1+\zeta_1\frac{V(x,y,z,\tau)}{V^*}+\zeta_2\frac{V^2(x,y,z,\tau)}{(V^*)^2}\right]\times \\
 & \times\frac{z}{kT}\left[1+\frac{\xi_S\alpha_{IC}^\gamma}{P^\gamma(x,y,z,T)}\right]d\tau\left\}+\alpha_{IC}\frac{\partial}{\partial y}\int_0^t D_{SL}(x,y,z,T)\left[1+\frac{\xi_S\alpha_{IC}^\gamma}{P^\gamma(x,y,z,T)}\right]\left[1+\frac{\xi_S\alpha_{IC}^\gamma}{P^\gamma(x,y,z,T)}\right]\times\right. \\
 & \left.\times z\frac{\Omega}{kT}\left[1+\zeta_1\frac{V(x,y,z,\tau)}{V^*}+\zeta_2\frac{V^2(x,y,z,\tau)}{(V^*)^2}\right]d\tau+f_C(x,y,z)\right. \tag{1e}
 \end{aligned}$$

$$I_1(x,y,z,t)=f_I(x,y,z)-\alpha_{II}^2\int_0^t k_{I,I}(x,y,z,T)d\tau-\alpha_{II}\alpha_{IV}\int_0^t k_{I,V}(x,y,z,T)d\tau$$

$$+\alpha_{II}z\Omega\frac{\partial}{\partial x}\int_0^t\frac{D_{IS}}{kT}\nabla_S\mu(x,y,z,\tau)d\tau+\alpha_{II}z\Omega\frac{\partial}{\partial y}\int_0^t\frac{D_{IS}}{kT}\nabla_S\mu(x,y,z,\tau)d\tau$$

$$V_1(x,y,z,t)=f_V(x,y,z)-\alpha_{IV}^2\int_0^t k_{V,V}(x,y,z,T)d\tau-\alpha_{IV}\alpha_{IV}\int_0^t k_{I,V}(x,y,z,T)d\tau+$$

$$+\alpha_{IV}z\Omega\frac{\partial}{\partial x}\int_0^t\frac{D_{IS}}{kT}\nabla_S\mu(x,y,z,\tau)d\tau+\alpha_{IV}z\Omega\frac{\partial}{\partial y}\int_0^t\frac{D_{IS}}{kT}\nabla_S\mu(x,y,z,\tau)d\tau$$

$$\Phi_{II}(x,y,z,t)=f_{\Phi_I}(x,y,z)+\alpha_{I\Phi_I}z\Omega\frac{\partial}{\partial x}\int_0^t\frac{D_{\Phi_I S}}{kT}\nabla_S\mu(x,y,z,\tau)d\tau+\int_0^t k_I(x,y,z,T)I(x,y,z,\tau)d\tau+$$

$$+\alpha_{I\Phi_I}z\Omega\frac{\partial}{\partial y}\int_0^t\frac{D_{\Phi_I S}}{kT}\nabla_S\mu(x,y,z,\tau)d\tau+\int_0^t k_{I,I}(x,y,z,T)I^2(x,y,z,\tau)d\tau \tag{5c}$$



$$\begin{aligned} \Phi_{IV}(x, y, z, t) = & f_{\Phi_V}(x, y, z) + \alpha_{1\Phi_V} z \Omega \frac{\partial}{\partial x} \int_0^t \frac{D_{\Phi_V S}}{kT} \nabla_S \mu(x, y, z, \tau) d\tau + \int_0^t k_V(x, y, z, T) V(x, y, z, \tau) d\tau + \\ & + \alpha_{1\Phi_V} z \Omega \frac{\partial}{\partial y} \int_0^t \frac{D_{\Phi_V S}}{kT} \nabla_S \mu(x, y, z, \tau) d\tau + \int_0^t k_{V,V}(x, y, z, T) V^2(x, y, z, \tau) d\tau \end{aligned}$$

We determine average values of the first-order approximations of required functions by using the following relations [17,18]

$$\alpha_{1\rho} = \frac{1}{\Theta L_x L_y L_z} \int_0^{\Theta} \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} \rho_1(x, y, z, t) dz dy dx dt \tag{9}$$

Substitution of these relations (1c), (3c) and (5c) into relation (9) gives us a possibility to obtain the following relations

$$\begin{aligned} \alpha_{1C} = \frac{1}{L_x L_y L_z} \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} f_C(x, y, z) dz dy dx \quad \alpha_{1I} = & \sqrt{\frac{(a_3 + A)^2}{4a_4^2} - 4 \left( B + \frac{\Theta a_3 B + \Theta^2 L_x L_y L_z a_1}{a_4} \right)} - \\ - \frac{a_3 + A}{4a_4} \alpha_{1V} = & \frac{1}{S_{IV00}} \left[ \frac{\Theta}{\alpha_{1I}} \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} f_I(x, y, z) dz dy dx - \alpha_{1I} S_{II00} - \Theta L_x L_y L_z \right] \end{aligned}$$

Where

$$S_{\rho\rho ij} = \int_0^{\Theta} (\Theta - t) \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} k_{\rho,\rho}(x, y, z, T) I_1^i(x, y, z, t) V_1^j(x, y, z, t) dz dy dx dt$$

$$a_4 = S_{II00} (S_{IV00}^2 - S_{II00} S_{VV00})$$

$$a_3 = S_{IV00} S_{II00} + S_{IV00}^2 - S_{II00} S_{VV00}$$

$$a_2 = S_{IV00} S_{IV00}^2 \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} f_V(x, y, z) dz dy dx + 2 S_{VV00} S_{II00} \times$$

$$\times \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} f_I(x, y, z) dz dy dx - S_{IV00}^2 \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} f_I(x, y, z) dz dy dx - \Theta L_x^2 L_y^2 L_z^2 S_{VV00} + S_{IV00} \Theta L_x^2 L_y^2 L_z^2$$

$$a_1 = S_{IV00} \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} f_I(x, y, z) dz dy dx$$

$$a_0 = S_{VV00} \left[ \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} f_I(x, y, z) dz dy dx \right]^2$$

$$A = \sqrt{8y + \Theta^2 \frac{a_3^2}{a_4^2} - 4\Theta \frac{a_2}{a_4}}$$

$$B = \frac{\Theta a_2}{6a_4} + \sqrt[3]{\sqrt{q^2 + p^3} - q} - \sqrt[3]{\sqrt{q^2 + p^3} + q}$$

$$q = \frac{\Theta^3 a_2}{24 a_4^2} \left( 4a_0 - \Theta L_x L_y L_z \frac{a_1 a_3}{a_4} \right) - L_x^2 L_y^2 L_z^2 \frac{\Theta^4 a_1^2}{8 a_4^2} -$$

$$-\Theta^2 \frac{a_0}{8a_4^2} \left( 4\Theta a_2 - \Theta^2 \frac{a_3^2}{a_4} \right) - \frac{\Theta^3 a_2^3}{54a_4^3} p = \frac{a_0 \Theta^2}{3a_4} - L_x L_y L_z \Theta^3 \frac{a_1 a_3}{12a_4^2} - \frac{\Theta a_2}{18a_4}$$

$$\alpha_{1\Phi_i} = \frac{R_{I1}}{\Theta L_x L_y L_z} + \frac{S_{II20}}{\Theta L_x L_y L_z} + \frac{1}{L_x L_y L_z} \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} f_{\Phi_i}(x, y, z) dz dy dx$$

$$\alpha_{1\Phi_v} = \frac{R_{V1}}{\Theta L_x L_y L_z} + \frac{S_{VV20}}{\Theta L_x L_y L_z} + \frac{1}{L_x L_y L_z} \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} f_{\Phi_v}(x, y, z) dz dy dx$$

Where

$$R_{\rho_i} = \int_0^\Theta (\Theta - t) \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} k_I(x, y, z, T) I_1^i(x, y, z, t) dz dy dx dt$$

Approximations of the above concentrations of the second and higher orders we obtain framework standard iterative procedure of method of averaging of function corrections [17,18]. Framework the procedure to determine approximations with the  $n$ -th-order approximations of concentrations of dopant and radiation defects we replace the required concentrations  $C(x, y, z, t)$ ,  $I(x, y, z, t)$ ,  $V(x, y, z, t)$ ,  $\Phi_1(x, y, z, t)$  and  $\Phi_v(x, y, z, t)$  in right sides of Eqs. (1), (4) and (6) on sums of the following sums  $\alpha_{np} + \rho_{n-1}(x, y, z, t)$ , where  $\alpha_{np}$  are the average values of  $n$ -th-order approximations of concentrations of dopant and defects  $\rho_{n-1}(x, y, z, t)$ . The replacement leads to the following results

$$\begin{aligned} & + \zeta_1 \frac{V(x, y, z, t)}{V^*} \left] D_L(x, y, z, T) \right) + \frac{\partial}{\partial y} \left( D_L(x, y, z, T) \left[ 1 + \zeta_1 \frac{V(x, y, z, t)}{V^*} + \zeta_2 \frac{V^2(x, y, z, t)}{(V^*)^2} \right] \right) \times \\ & \frac{\partial C_2(x, y, z, t)}{\partial t} = \frac{\partial}{\partial x} \left( \frac{\partial C_1(x, y, z, t)}{\partial x} \left\{ 1 + \xi \frac{[\alpha_{2c} + C_1(x, y, z, t)]^\gamma}{P^\gamma(x, y, z, T)} \right\} \left[ 1 + \zeta_2 \frac{V^2(x, y, z, t)}{(V^*)^2} + \right. \right. \\ & \times \left. \left. \left\{ 1 + \xi \frac{[\alpha_{2c} + C_1(x, y, z, t)]^\gamma}{P^\gamma(x, y, z, T)} \right\} \frac{\partial C_1(x, y, z, t)}{\partial y} \right) + \frac{\partial}{\partial z} \left( D_L(x, y, z, T) \left[ 1 + \zeta_2 \frac{V^2(x, y, z, t)}{(V^*)^2} + \right. \right. \right. \\ & \left. \left. \left. + \zeta_1 \frac{V(x, y, z, t)}{V^*} \right] \frac{\partial C_1(x, y, z, t)}{\partial z} \left\{ 1 + \xi \frac{[\alpha_{2c} + C_1(x, y, z, t)]^\gamma}{P^\gamma(x, y, z, T)} \right\} \right) + \Omega \frac{\partial}{\partial x} \left\{ \nabla_s \mu_2(x, y, z, t) \times \right. \right. \\ & \times \left. \left. \frac{D_{CS}}{kT} \int_0^{L_z} [\alpha_{2c} + C_1(x, y, W, t)] dW \right\} + \frac{\partial}{\partial y} \left\{ \Omega \nabla_s \mu_2(x, y, z, t) \frac{D_{CS}}{kT} \int_0^{L_z} [\alpha_{2c} + C_1(x, y, W, t)] dW \right\} + \right. \\ & \left. + \frac{\partial}{\partial x} \left[ \frac{D_{CS}}{\bar{V} kT} \frac{\partial \mu_1(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ \frac{D_{CS}}{\bar{V} kT} \frac{\partial \mu_1(x, y, z, t)}{\partial y} \right] + \frac{\partial}{\partial z} \left[ \frac{D_{CS}}{\bar{V} kT} \frac{\partial \mu_1(x, y, z, t)}{\partial z} \right] \right) \\ & \frac{\partial I_2(x, y, z, t)}{\partial t} = \frac{\partial}{\partial x} \left[ D_I(x, y, z, T) \frac{\partial I_1(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ D_I(x, y, z, T) \frac{\partial I_1(x, y, z, t)}{\partial y} \right] - \\ & - k_{I,v}(x, y, z, T) [\alpha_{2I} + I_1(x, y, z, t)] [\alpha_{2V} + V_1(x, y, z, t)] + \frac{\partial}{\partial z} \left[ D_I(x, y, z, T) \frac{\partial I_1(x, y, z, t)}{\partial z} \right] + \end{aligned}$$

$$\begin{aligned}
 & + \frac{\partial}{\partial x} \left[ \frac{D_{IS}}{\bar{V}kT} \frac{\partial \mu_1(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ \frac{D_{IS}}{\bar{V}kT} \frac{\partial \mu_1(x, y, z, t)}{\partial y} \right] + \frac{\partial}{\partial z} \left[ \frac{D_{IS}}{\bar{V}kT} \frac{\partial \mu_1(x, y, z, t)}{\partial z} \right] - \\
 & + \Omega \frac{\partial}{\partial x} \left\{ \frac{D_{IS}}{kT} \nabla_s \mu_2(x, y, z, t) \int_0^{L_z} [\alpha_{2I} + I_1(x, y, W, t)] dW \right\} - k_{I,I}(x, y, z, T) \times \\
 & \times \left[ \alpha_{2I} + I_1(x, y, z, t) \right]^2 + \Omega \frac{\partial}{\partial y} \left\{ \frac{D_{IS}}{kT} \nabla_s \mu_2(x, y, z, t) \int_0^{L_z} [\alpha_{2I} + I_1(x, y, W, t)] dW \right\} \\
 \frac{\partial V_2(x, y, z, t)}{\partial t} & = \frac{\partial}{\partial x} \left[ D_V(x, y, z, T) \frac{\partial V_1(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ D_V(x, y, z, T) \frac{\partial V_1(x, y, z, t)}{\partial y} \right] - \\
 & - k_{I,V}(x, y, z, T) [\alpha_{2I} + I_1(x, y, z, t)] [\alpha_{2V} + V_1(x, y, z, t)] + \frac{\partial}{\partial z} \left[ D_V(x, y, z, T) \frac{\partial V_1(x, y, z, t)}{\partial z} \right] + \\
 & + \frac{\partial}{\partial x} \left[ \frac{D_{VS}}{\bar{V}kT} \frac{\partial \mu_1(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ \frac{D_{VS}}{\bar{V}kT} \frac{\partial \mu_1(x, y, z, t)}{\partial y} \right] + \frac{\partial}{\partial z} \left[ \frac{D_{VS}}{\bar{V}kT} \frac{\partial \mu_1(x, y, z, t)}{\partial z} \right] - \\
 & + \Omega \frac{\partial}{\partial x} \left\{ \frac{D_{VS}}{kT} \nabla_s \mu_2(x, y, z, t) \int_0^{L_z} [\alpha_{2V} + V_1(x, y, W, t)] dW \right\} - k_{V,V}(x, y, z, T) [\alpha_{2V} + V_1(x, y, z, t)]^2 + \\
 & + \Omega \frac{\partial}{\partial y} \left\{ \frac{D_{VS}}{kT} \nabla_s \mu_2(x, y, z, t) \int_0^{L_z} [\alpha_{2V} + V_1(x, y, W, t)] dW \right\} \\
 \frac{\partial \Phi_{I2}(x, y, z, t)}{\partial t} & = \frac{\partial}{\partial x} \left[ D_{\Phi I}(x, y, z, T) \frac{\partial \Phi_{I1}(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ D_{\Phi I}(x, y, z, T) \frac{\partial \Phi_{I1}(x, y, z, t)}{\partial y} \right] + \\
 & + \frac{\partial}{\partial z} \left[ D_{\Phi I}(x, y, z, T) \frac{\partial \Phi_{I1}(x, y, z, t)}{\partial z} \right] + k_{I,I}(x, y, z, T) I^2(x, y, z, t) - k_I(x, y, z, T) I(x, y, z, t) + \\
 & + \frac{\partial}{\partial x} \left[ \frac{D_{\Phi IS}}{\bar{V}kT} \frac{\partial \mu_1(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ \frac{D_{\Phi IS}}{\bar{V}kT} \frac{\partial \mu_1(x, y, z, t)}{\partial y} \right] + \frac{\partial}{\partial z} \left[ \frac{D_{\Phi IS}}{\bar{V}kT} \frac{\partial \mu_1(x, y, z, t)}{\partial z} \right] + \\
 & + \Omega \frac{\partial}{\partial x} \left\{ \frac{D_{\Phi IS}}{kT} \nabla_s \mu_2(x, y, z, t) \int_0^{L_z} [\alpha_{2\Phi I} + \Phi_{I1}(x, y, W, t)] dW \right\} + \\
 & + \Omega \frac{\partial}{\partial y} \left\{ \frac{D_{\Phi IS}}{kT} \nabla_s \mu_2(x, y, z, t) \int_0^{L_z} [\alpha_{2\Phi I} + \Phi_{I1}(x, y, W, t)] dW \right\} \\
 \frac{\partial \Phi_{V2}(x, y, z, t)}{\partial t} & = \frac{\partial}{\partial x} \left[ D_{\Phi V}(x, y, z, T) \frac{\partial \Phi_{V1}(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ D_{\Phi V}(x, y, z, T) \frac{\partial \Phi_{V1}(x, y, z, t)}{\partial y} \right] + \\
 & + \frac{\partial}{\partial z} \left[ D_{\Phi V}(x, y, z, T) \frac{\partial \Phi_{V1}(x, y, z, t)}{\partial z} \right] + k_{V,V}(x, y, z, T) V^2(x, y, z, t) - k_V(x, y, z, T) V(x, y, z, t) +
 \end{aligned}$$

$$\begin{aligned}
 & + \frac{\partial}{\partial x} \left[ \frac{D_{\Phi VS}}{\bar{V} k T} \frac{\partial \mu_1(x, y, z, t)}{\partial x} \right] + \frac{\partial}{\partial y} \left[ \frac{D_{\Phi VS}}{\bar{V} k T} \frac{\partial \mu_1(x, y, z, t)}{\partial y} \right] + \frac{\partial}{\partial z} \left[ \frac{D_{\Phi VS}}{\bar{V} k T} \frac{\partial \mu_1(x, y, z, t)}{\partial z} \right] + \\
 & + \Omega \frac{\partial}{\partial x} \left\{ \frac{D_{\Phi VS}}{k T} \nabla_s \mu_2(x, y, z, t) \int_0^{L_z} [\alpha_{2\Phi V} + \Phi_{V1}(x, y, W, t)] dW \right\} + \\
 & + \Omega \frac{\partial}{\partial y} \left\{ \frac{D_{\Phi VS}}{k T} \nabla_s \mu_2(x, y, z, t) \int_0^{L_z} [\alpha_{2\Phi V} + \Phi_{V1}(x, y, W, t)] dW \right\}
 \end{aligned}$$

Integration of the left and right sides of Eqs. (1d), (3d), (5d) gives us possibility to obtain relations for the second-order approximations of dopant and radiation defects in the following form

$$\begin{aligned}
 C_2(x, y, z, t) = & \frac{\partial}{\partial x} \left( \int_0^t D_L(x, y, z, T) \left[ 1 + \varsigma_1 \frac{V(x, y, z, \tau)}{V^*} + \varsigma_2 \frac{V^2(x, y, z, \tau)}{(V^*)^2} \right] \frac{\partial C_1(x, y, z, \tau)}{\partial x} \times \right. \\
 & \times \left. \left\{ 1 + \xi \frac{[\alpha_{2C} + C_1(x, y, z, \tau)]^\gamma}{P^\gamma(x, y, z, T)} \right\} d\tau + \frac{\partial}{\partial y} \left( \int_0^t \left[ 1 + \varsigma_1 \frac{V(x, y, z, \tau)}{V^*} + \varsigma_2 \frac{V^2(x, y, z, \tau)}{(V^*)^2} \right] \times \right. \\
 & \times D_L(x, y, z, T) \left\{ 1 + \xi \frac{[\alpha_{2C} + C_1(x, y, z, \tau)]^\gamma}{P^\gamma(x, y, z, T)} \right\} \frac{\partial C_1(x, y, z, \tau)}{\partial y} d\tau \right) + \frac{\partial}{\partial z} \left( \int_0^t D_L(x, y, z, T) \times \right. \\
 & \times \left. \left[ 1 + \varsigma_1 \frac{V(x, y, z, \tau)}{V^*} + \varsigma_2 \frac{V^2(x, y, z, \tau)}{(V^*)^2} \right] \left\{ 1 + \xi \frac{[\alpha_{2C} + C_1(x, y, z, \tau)]^\gamma}{P^\gamma(x, y, z, T)} \right\} \frac{\partial C_1(x, y, z, \tau)}{\partial z} d\tau \right) + \\
 & + \frac{\partial}{\partial x} \left( \int_0^t D_{LS}(x, y, z, T) \left[ 1 + \varsigma_1 \frac{V(x, y, z, \tau)}{V^*} + \varsigma_2 \frac{V^2(x, y, z, \tau)}{(V^*)^2} \right] \left\{ 1 + \xi \frac{[\alpha_{2C} + C_1(x, y, z, \tau)]^\gamma}{P^\gamma(x, y, z, T)} \right\} \times \right. \\
 & \times \left. \frac{\partial \mu_1(x, y, z, \tau)}{\partial x} d\tau \right) + \frac{\partial}{\partial y} \left( \int_0^t \frac{\partial \mu_1(x, y, z, \tau)}{\partial x} \left[ 1 + \varsigma_1 \frac{V(x, y, z, \tau)}{V^*} + \varsigma_2 \frac{V^2(x, y, z, \tau)}{(V^*)^2} \right] \times \right. \\
 & \times D_{LS}(x, y, z, T) \left\{ 1 + \xi \frac{[\alpha_{2C} + C_1(x, y, z, \tau)]^\gamma}{P^\gamma(x, y, z, T)} \right\} d\tau \right) + \frac{\partial}{\partial z} \left( \int_0^t D_{LS}(x, y, z, T) \frac{\partial \mu_1(x, y, z, \tau)}{\partial x} \times \right. \\
 & \times \left. \left[ 1 + \varsigma_1 \frac{V(x, y, z, \tau)}{V^*} + \varsigma_2 \frac{V^2(x, y, z, \tau)}{(V^*)^2} \right] \left\{ 1 + \xi \frac{[\alpha_{2C} + C_1(x, y, z, \tau)]^\gamma}{P^\gamma(x, y, z, T)} \right\} \frac{\partial \mu_1(x, y, z, \tau)}{\partial x} d\tau \right) +
 \end{aligned}$$

$$\begin{aligned}
 & +\Omega \frac{\partial}{\partial x} \left( \int_0^t \left[ 1 + \zeta_1 \frac{V(x, y, z, \tau)}{V^*} + \zeta_2 \frac{V^2(x, y, z, \tau)}{(V^*)^2} \right] \left\{ 1 + \xi \frac{[\alpha_{2C} + C_1(x, y, z, \tau)]^\gamma}{P^\gamma(x, y, z, T)} \right\} \times \right. \\
 & \times \frac{D_{LS}(x, y, z, T)}{kT} \nabla_s \mu_2(x, y, z, \tau) \int_0^{L_z} [\alpha_{2C} + C_1(x, y, W, \tau)] dW \Big) d\tau + \frac{\partial}{\partial y} \left( \int_0^t \frac{D_{LS}(x, y, z, T)}{kT} \times \right. \\
 & \times \nabla_s \mu_2(x, y, z, \tau) \left[ 1 + \zeta_1 \frac{V(x, y, z, \tau)}{V^*} + \zeta_2 \frac{V^2(x, y, z, \tau)}{(V^*)^2} \right] \left\{ 1 + \xi \frac{[\alpha_{2C} + C_1(x, y, z, \tau)]^\gamma}{P^\gamma(x, y, z, T)} \right\} \times \\
 & \left. \times \Omega \int_0^{L_z} [\alpha_{2C} + C_1(x, y, W, \tau)] dW \right) d\tau + f_C(x, y, z) \tag{1e}
 \end{aligned}$$

$$\begin{aligned}
 I_2(x, y, z, t) &= \frac{\partial}{\partial x} \left[ \int_0^t D_I(x, y, z, T) \frac{\partial I_1(x, y, z, \tau)}{\partial x} d\tau \right] + \frac{\partial}{\partial y} \left[ \int_0^t D_I(x, y, z, T) \frac{\partial I_1(x, y, z, \tau)}{\partial y} d\tau \right] + \\
 & + \frac{\partial}{\partial z} \left[ \int_0^t D_I(x, y, z, T) \frac{\partial I_1(x, y, z, \tau)}{\partial z} d\tau \right] - \int_0^t k_{I,I}(x, y, z, T) [\alpha_{2I} + I_1(x, y, z, \tau)]^2 d\tau - \\
 & + \frac{\partial}{\partial x} \int_0^t \frac{D_{IS}}{\bar{V} kT} \frac{\partial \mu_1(x, y, z, \tau)}{\partial x} d\tau + \frac{\partial}{\partial y} \int_0^t \frac{D_{IS}}{\bar{V} kT} \frac{\partial \mu_1(x, y, z, \tau)}{\partial y} d\tau + \frac{\partial}{\partial z} \int_0^t \frac{\partial \mu_1(x, y, z, \tau)}{\partial z} \frac{D_{IS} d\tau}{\bar{V} kT} - \\
 & - \int_0^t k_{I,V}(x, y, z, T) [\alpha_{2I} + I_1(x, y, z, \tau)] [\alpha_{2V} + V_1(x, y, z, \tau)] d\tau + \Omega \frac{\partial}{\partial x} \int_0^t \frac{D_{IS}}{kT} \nabla_s \mu_2(x, y, z, \tau) \times \\
 & \times \int_0^{L_z} [\alpha_{2I} + I_1(x, y, W, \tau)] dW d\tau + \Omega \frac{\partial}{\partial y} \int_0^t \frac{D_{IS}}{kT} \int_0^{L_z} [\alpha_{2I} + I_1(x, y, W, \tau)] dW \nabla_s \mu_2(x, y, z, \tau) d\tau \\
 & \times \int_0^{L_z} [\alpha_{2I} + I_1(x, y, W, \tau)] dW d\tau + \Omega \frac{\partial}{\partial y} \int_0^t \frac{D_{IS}}{kT} \int_0^{L_z} [\alpha_{2I} + I_1(x, y, W, \tau)] dW \nabla_s \mu_2(x, y, z, \tau) d\tau \tag{3e}
 \end{aligned}$$

$$\begin{aligned}
 V_2(x, y, z, t) &= \frac{\partial}{\partial x} \left[ \int_0^t D_V(x, y, z, T) \frac{\partial V_1(x, y, z, \tau)}{\partial x} d\tau \right] + \frac{\partial}{\partial y} \left[ \int_0^t D_V(x, y, z, T) \frac{\partial V_1(x, y, z, \tau)}{\partial y} d\tau \right] + \\
 & + \frac{\partial}{\partial z} \left[ \int_0^t D_V(x, y, z, T) \frac{\partial V_1(x, y, z, \tau)}{\partial z} d\tau \right] - \int_0^t k_{V,V}(x, y, z, T) [\alpha_{2V} + V_1(x, y, z, \tau)]^2 d\tau - \\
 & + \frac{\partial}{\partial x} \int_0^t \frac{D_{VS}}{\bar{V} kT} \frac{\partial \mu_1(x, y, z, \tau)}{\partial x} d\tau + \frac{\partial}{\partial y} \int_0^t \frac{D_{VS}}{\bar{V} kT} \frac{\partial \mu_1(x, y, z, \tau)}{\partial y} d\tau + \frac{\partial}{\partial z} \int_0^t \frac{\partial \mu_1(x, y, z, \tau)}{\partial z} \frac{D_{VS} d\tau}{\bar{V} kT} - \\
 & - \int_0^t k_{I,V}(x, y, z, T) [\alpha_{2I} + I_1(x, y, z, \tau)] [\alpha_{2V} + V_1(x, y, z, \tau)] d\tau + \Omega \frac{\partial}{\partial x} \int_0^t \frac{D_{VS}}{kT} \nabla_s \mu_2(x, y, z, \tau) \times \\
 & \times \int_0^{L_z} [\alpha_{2V} + V_1(x, y, W, \tau)] dW d\tau + \Omega \frac{\partial}{\partial y} \int_0^t \frac{D_{VS}}{kT} \int_0^{L_z} [\alpha_{2V} + V_1(x, y, W, \tau)] dW \nabla_s \mu_2(x, y, z, \tau) d\tau
 \end{aligned}$$

$$\begin{aligned}
 \Phi_{I2}(x, y, z, t) = & \frac{\partial}{\partial x} \left[ \int_0^t D_{\Phi I} (x, y, z, T) \frac{\partial \Phi_{I1}(x, y, z, \tau)}{\partial x} d\tau \right] + \frac{\partial}{\partial y} \left[ \int_0^t D_{\Phi I} (x, y, z, T) \frac{\partial \Phi_{I1}(x, y, z, \tau)}{\partial y} d\tau \right] + \\
 & + \frac{\partial}{\partial z} \left[ \int_0^t D_{\Phi I} (x, y, z, T) \frac{\partial \Phi_{I1}(x, y, z, \tau)}{\partial z} d\tau \right] + \frac{\partial}{\partial x} \int_0^t \frac{D_{\Phi IS}}{\bar{V} k T} \frac{\partial \mu_1(x, y, z, \tau)}{\partial x} d\tau + \frac{\partial}{\partial y} \int_0^t \frac{\partial \mu_1(x, y, z, \tau)}{\partial y} \times \\
 & \times \frac{D_{\Phi IS}}{\bar{V} k T} d\tau + \Omega \frac{\partial}{\partial x} \left\{ \int_0^t \frac{D_{\Phi IS}}{k T} \nabla_S \mu_2(x, y, z, \tau) \int_0^{L_z} [\alpha_{2\Phi I} + \Phi_{I1}(x, y, W, \tau)] dW d\tau \right\} + \frac{\partial}{\partial z} \int_0^t \frac{D_{\Phi IS}}{\bar{V} k T} \times \\
 & \times \frac{\partial \mu_1(x, y, z, \tau)}{\partial z} d\tau + \Omega \frac{\partial}{\partial y} \left\{ \int_0^t \frac{D_{\Phi IS}}{k T} \nabla_S \mu_2(x, y, z, \tau) \int_0^{L_z} [\alpha_{2\Phi I} + \Phi_{I1}(x, y, W, \tau)] dW d\tau \right\} - \\
 & - \int_0^t k_I(x, y, z, T) I(x, y, z, \tau) d\tau + \int_0^t k_{I,I}(x, y, z, T) I^2(x, y, z, \tau) d\tau + f_{\Phi I}(x, y, z)
 \end{aligned} \tag{5e}$$

$$\begin{aligned}
 \Phi_{V2}(x, y, z, t) = & \frac{\partial}{\partial x} \left[ \int_0^t D_{\Phi V} (x, y, z, T) \frac{\partial \Phi_{V1}(x, y, z, \tau)}{\partial x} d\tau \right] + \frac{\partial}{\partial y} \left[ \int_0^t D_{\Phi V} (x, y, z, T) \frac{\partial \Phi_{V1}(x, y, z, \tau)}{\partial y} d\tau \right] + \\
 & + \frac{\partial}{\partial z} \left[ \int_0^t D_{\Phi V} (x, y, z, T) \frac{\partial \Phi_{V1}(x, y, z, \tau)}{\partial z} d\tau \right] + \frac{\partial}{\partial x} \int_0^t \frac{D_{\Phi VS}}{\bar{V} k T} \frac{\partial \mu_1(x, y, z, \tau)}{\partial x} d\tau + \frac{\partial}{\partial y} \int_0^t \frac{D_{\Phi VS}}{\bar{V} k T} \times \\
 & \times \frac{\partial \mu_1(x, y, z, \tau)}{\partial y} d\tau + \Omega \frac{\partial}{\partial x} \left\{ \int_0^t \frac{D_{\Phi VS}}{k T} \nabla_S \mu_2(x, y, z, \tau) \int_0^{L_z} [\alpha_{2\Phi V} + \Phi_{V1}(x, y, W, \tau)] dW d\tau \right\} + \\
 & + \Omega \frac{\partial}{\partial y} \left\{ \int_0^t \frac{D_{\Phi VS}}{k T} \nabla_S \mu_2(x, y, z, \tau) \int_0^{L_z} [\alpha_{2\Phi V} + \Phi_{V1}(x, y, W, \tau)] dW d\tau \right\} + \frac{\partial}{\partial z} \int_0^t \frac{D_{\Phi VS}}{\bar{V} k T} \frac{\partial \mu_1(x, y, z, \tau)}{\partial z} d\tau + \\
 & + \int_0^t k_{V,V}(x, y, z, T) V^2(x, y, z, \tau) d\tau - \int_0^t k_V(x, y, z, T) V(x, y, z, \tau) d\tau + f_{\Phi V}(x, y, z)
 \end{aligned}$$

We determine average values of the second-order approximations of required functions by using of the standard relation [17,18]

$$\alpha_{2\rho} = \frac{1}{\Theta L_x L_y L_z} \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} [\rho_2(x, y, z, t) - \rho_1(x, y, z, t)] dz dy dx dt \tag{10}$$

Substitution of the relations (1e), (3e), (5e) into relation (10) gives us possibility to obtain relations for the parameter  $\alpha_{2\rho}$

$$\begin{aligned}
 \alpha_{2C}=0, \alpha_{2\Phi I}=0, \alpha_{2\Phi V}=0, \alpha_{2V} = & \sqrt{\frac{(b_3 + E)^2}{4b_4^2} - 4 \left( F + \frac{\Theta a_3 F + \Theta^2 L_x L_y L_z b_1}{b_4} \right)} - \frac{b_3 + E}{4b_4}, \\
 \alpha_{2I} = & \frac{C_V - \alpha_{2V}^2 S_{VV00} - \alpha_{2V} (2S_{VV01} + S_{IV10} + \Theta L_x L_y L_z) - S_{VV02} - S_{IV11}}{S_{IV01} + \alpha_{2V} S_{IV00}}
 \end{aligned}$$

where

$$\begin{aligned}
 b_4 &= \frac{1}{\Theta L_x L_y L_z} S_{IV00}^2 S_{VV00} - \frac{1}{\Theta L_x L_y L_z} S_{VV00}^2 S_{II00} \\
 b_3 &= -\frac{S_{II00} S_{VV00}}{\Theta L_x L_y L_z} (2S_{VV01} + S_{IV10} + \Theta L_x L_y L_z) + \\
 &+ \frac{1}{\Theta L_x L_y L_z} (S_{IV01} + 2S_{II10} + S_{IV01} + \Theta L_x L_y L_z) S_{IV00} S_{VV00} + \frac{S_{IV00}^2}{\Theta L_x L_y L_z} (2S_{VV01} + S_{IV10} + \Theta L_x L_y L_z) - \\
 &- \frac{S_{IV00}^2 S_{IV10}}{\Theta^3 L_x^3 L_y^3 L_z^3} b_2 = \frac{S_{II00} S_{VV00}}{\Theta L_x L_y L_z} (S_{VV02} + S_{IV11} + C_V) - (\Theta L_x L_y L_z - 2S_{VV01} + S_{IV10})^2 + \frac{S_{IV01} S_{VV00}}{\Theta L_x L_y L_z} \times \\
 &+ \frac{S_{IV01} S_{VV00}}{\Theta L_x L_y L_z} (\Theta L_x L_y L_z + 2S_{II10} + S_{IV01}) + S_{IV00} \frac{\Theta L_x L_y L_z + S_{IV01} + 2S_{II10} + 2S_{IV01}}{\Theta L_x L_y L_z} (2S_{VV01} + S_{IV10} + \\
 &+ \Theta L_x L_y L_z) - S_{IV00}^2 \frac{C_V - S_{VV02} - S_{IV11}}{\Theta L_x L_y L_z} + \frac{C_I S_{IV00}^2}{\Theta^2 L_x^2 L_y^2 L_z^2} - \frac{2}{\Theta L_x L_y L_z} S_{IV10} S_{IV00} S_{IV01} \quad b_1 = S_{II00} \times \\
 &\times (2S_{VV01} + S_{IV10} + \Theta L_x L_y L_z) \frac{S_{IV11} + S_{VV02} + C_V}{\Theta L_x L_y L_z} + \frac{S_{IV01}}{\Theta L_x L_y L_z} (\Theta L_x L_y L_z + 2S_{II10} + S_{IV01}) (2S_{VV01} + \\
 &+ S_{IV10} + \Theta L_x L_y L_z) - S_{IV00} \frac{3S_{IV01} + 2S_{II10} + \Theta L_x L_y L_z}{\Theta L_x L_y L_z} (C_V - S_{VV02} - S_{IV11}) + 2C_I S_{IV00} S_{IV01} - \frac{S_{IV10}}{\Theta L_x} \times \\
 &\times \frac{S_{IV01}^2}{L_y L_z} b_0 = \frac{S_{II00}}{\Theta L_x L_y L_z} (S_{IV00} + S_{VV02})^2 - S_{IV01} \frac{C_V - S_{IV11} - S_{VV02}}{\Theta L_x L_y L_z} (\Theta L_x L_y L_z + 2S_{II10} + S_{IV01}) + \\
 &+ 2C_I S_{IV01}^2 - \frac{S_{IV01}}{\Theta L_x L_y L_z} (\Theta L_x L_y L_z + 2S_{II10} + S_{IV01}) (C_V - S_{VV02} - S_{IV11}) \quad C_I = \frac{\alpha_{1I} \alpha_{1V} S_{IV00}}{\Theta L_x L_y L_z} + \\
 &+ \frac{\alpha_{1I}^2 S_{II00}}{\Theta L_x L_y L_z} - \frac{S_{II20} S_{II20}}{\Theta L_x L_y L_z} - \frac{\alpha_{1V} S_{IV11} S_{IV00}}{\Theta L_x L_y L_z} + \frac{\alpha_{1I}^2 S_{II00}}{\Theta L_x L_y L_z} - \frac{S_{II20} S_{II20}}{\Theta L_x L_y L_z} - \frac{S_{IV11}}{\Theta L_x L_y L_z} c \quad C_V = \alpha_{1I} \alpha_{1V} \times \\
 &\times S_{IV00} + \alpha_{1V}^2 S_{VV00} - S_{VV02} - S_{IV11} \\
 E &= \sqrt{8y + \Theta^2 \frac{a_3^2}{a_4^2} - 4\Theta \frac{a_2}{a_4}}, \quad F = \sqrt[3]{\sqrt{r^2 + s^3} - r} - \sqrt[3]{\sqrt{r^2 + s^3} + r} + \frac{\Theta a_2}{6a_4} \\
 r &= \frac{\Theta^3 b_2}{24b_4^2} \left( 4b_0 - \Theta L_x L_y L_z \frac{b_1 b_3}{b_4} \right) - b_0 \frac{\Theta^2}{8b_4^2} \left( 4\Theta b_2 - \Theta^2 \frac{b_3^2}{b_4} \right) - \frac{\Theta^3 b_2^3}{54b_4^3} - L_x^2 L_y^2 L_z^2 \frac{\Theta^4 b_1^2}{8b_4^2} \\
 s &= -\Theta \left[ 2b_2 - 3\Theta (4b_0 b_4 - \Theta L_x L_y L_z b_1 b_3) / b_4 \right] / 36b_4
 \end{aligned}$$

After that we determine solutions of the system of Eqs. (8). The solutions physically correspond to components of

displacement vector. To determine components of displacement vector we used the method of averaging of function corrections in its standard form. By using this approach, we replace the above components in right sides of Eqs. (8) by their not yet known average values  $\alpha_i$ . The substitution leads to the following results.

$$\rho(z) \frac{\partial^2 u_{1x}(x, y, z, t)}{\partial t^2} = -K(z) \beta(z) \frac{\partial T(x, y, z, t)}{\partial x}$$

$$\rho(z) \frac{\partial^2 u_{1y}(x, y, z, t)}{\partial t^2} = -K(z) \beta(z) \frac{\partial T(x, y, z, t)}{\partial y}$$

$$\rho(z) \frac{\partial^2 u_{1z}(x, y, z, t)}{\partial t^2} = -K(z) \beta(z) \frac{\partial T(x, y, z, t)}{\partial z}$$

Integration of the left and right sides of the above equations on time t leads to final relations for the first-order approximations of components of displacement vector in the following form

$$u_{1x}(x, y, z, t) = K(z) \frac{\beta(z)}{\rho(z)} \frac{\partial}{\partial x} \int_0^t \int_0^g T(x, y, z, \tau) d\tau d\vartheta - K(z) \frac{\beta(z)}{\rho(z)} \frac{\partial}{\partial x} \int_0^\infty \int_0^g T(x, y, z, \tau) d\tau d\vartheta + u_{0x},$$

$$u_{1y}(x, y, z, t) = K(z) \frac{\beta(z)}{\rho(z)} \frac{\partial}{\partial y} \int_0^t \int_0^g T(x, y, z, \tau) d\tau d\vartheta - K(z) \frac{\beta(z)}{\rho(z)} \frac{\partial}{\partial y} \int_0^\infty \int_0^g T(x, y, z, \tau) d\tau d\vartheta + u_{0y},$$

$$u_{1z}(x, y, z, t) = K(z) \frac{\beta(z)}{\rho(z)} \frac{\partial}{\partial z} \int_0^t \int_0^g T(x, y, z, \tau) d\tau d\vartheta - K(z) \frac{\beta(z)}{\rho(z)} \frac{\partial}{\partial z} \int_0^\infty \int_0^g T(x, y, z, \tau) d\tau d\vartheta + u_{0z}$$

Approximations of the second-order and higher orders of components of displacement vector could be calculated by replacement of the required components in the Eqs. (8) by the following sums  $\alpha_1 + u_i(x, y, z, t)$  [16,17]. The replacement leads to the following result.

$$\begin{aligned} \rho(z) \frac{\partial^2 u_{2x}(x, y, z, t)}{\partial t^2} &= \left\{ K(z) + \frac{5E(z, C)}{6[1 + \sigma(z)]} \right\} \frac{\partial^2 u_{1x}(x, y, z, t)}{\partial x^2} + \left\{ K(z) - \frac{E(z, C)}{3[1 + \sigma(z)]} \right\} \frac{\partial^2 u_{1y}(x, y, z, t)}{\partial x \partial y} + \\ &+ \frac{E(z, C)}{2[1 + \sigma(z)]} \left[ \frac{\partial^2 u_{1y}(x, y, z, t)}{\partial y^2} + \frac{\partial^2 u_{1z}(x, y, z, t)}{\partial z^2} \right] + \left\{ K(z) + \frac{E(z, C)}{3[1 + \sigma(z)]} \right\} \frac{\partial^2 u_{1z}(x, y, z, t)}{\partial x \partial z} - \\ &- K(z) \beta(z) \frac{\partial T(x, y, z, t)}{\partial x} \\ \rho(z) \frac{\partial^2 u_{2y}(x, y, z, t)}{\partial t^2} &= \frac{E(z, C)}{2[1 + \sigma(z)]} \left[ \frac{\partial^2 u_{1y}(x, y, z, t)}{\partial x^2} + \frac{\partial^2 u_{1x}(x, y, z, t)}{\partial x \partial y} \right] - \beta(z) \frac{\partial T(x, y, z, t)}{\partial y} \times \\ &\times K(z) + \frac{\partial^2 u_{1y}(x, y, z, t)}{\partial y^2} \left\{ \frac{5E(z, C)}{12[1 + \sigma(z)]} + K(z) \right\} + \frac{1}{2} \frac{\partial}{\partial z} \left\{ \frac{E(z, C)}{1 + \sigma(z)} \left[ \frac{\partial u_{1y}(x, y, z, t)}{\partial z} + \frac{\partial u_{1z}(x, y, z, t)}{\partial y} \right] \right\} + \end{aligned}$$



$$\begin{aligned}
 & + \left\{ K(z) - \frac{E(z, C)}{6[1 + \sigma(z)]} \right\} \frac{\partial^2 u_{1y}(x, y, z, t)}{\partial y \partial z} + K(z) \frac{\partial^2 u_{1y}(x, y, z, t)}{\partial x \partial y} cc \\
 \rho(z) \frac{\partial^2 u_{2z}(x, y, z, t)}{\partial t^2} & = \frac{1}{2} \left[ \frac{\partial^2 u_{1z}(x, y, z, t)}{\partial x^2} + \frac{\partial^2 u_{1z}(x, y, z, t)}{\partial y^2} + \frac{\partial^2 u_{1x}(x, y, z, t)}{\partial x \partial z} + \frac{\partial^2 u_{1y}(x, y, z, t)}{\partial y \partial z} \right] \times \\
 & \times \frac{E(z, C)}{1 + \sigma(z)} + \frac{\partial}{\partial z} \left\{ K(z) \left[ \frac{\partial u_{1x}(x, y, z, t)}{\partial x} + \frac{\partial u_{1y}(x, y, z, t)}{\partial y} + \frac{\partial u_{1x}(x, y, z, t)}{\partial z} \right] \right\} + \frac{E(z, C)}{6[1 + \sigma(z)]} \times \\
 & \times \frac{\partial}{\partial z} \left\{ \left[ 6 \frac{\partial u_{1z}(x, y, z, t)}{\partial z} - \frac{\partial u_{1x}(x, y, z, t)}{\partial x} - \frac{\partial u_{1y}(x, y, z, t)}{\partial y} - \frac{\partial u_{1z}(x, y, z, t)}{\partial z} \right] \right\} - \frac{\partial T(x, y, z, t)}{\partial z} \times \\
 & \times K(z) \beta(z)
 \end{aligned}$$

Integration of left and right sides of the above equations on time t leads to the following results

$$\begin{aligned}
 u_{2x}(x, y, z, t) & = \frac{1}{\rho(z)} \left\{ K(z) + \frac{5E(z, C)}{6[1 + \sigma(z)]} \right\} \frac{\partial^2}{\partial x^2} \int_0^t \int_0^g u_{1x}(x, y, z, \tau) d\tau d\vartheta + \left\{ K(z) - \frac{E(z, C)}{3[1 + \sigma(z)]} \right\} \times \\
 & \times \frac{1}{\rho(z)} \frac{\partial^2}{\partial x \partial y} \int_0^t \int_0^g u_{1y}(x, y, z, \tau) d\tau d\vartheta + \left[ \frac{\partial^2}{\partial y^2} \int_0^t \int_0^g u_{1y}(x, y, z, \tau) d\tau d\vartheta + \frac{\partial^2}{\partial z^2} \int_0^t \int_0^g u_{1z}(x, y, z, \tau) d\tau d\vartheta \right] \times \\
 & \times \frac{1}{2\rho(z)} \frac{E(z, C)}{1 + \sigma(z)} + \frac{1}{\rho(z)} \frac{\partial^2}{\partial x \partial z} \int_0^t \int_0^g u_{1z}(x, y, z, \tau) d\tau d\vartheta \left\{ K(z) + \frac{E(z, C)}{3[1 + \sigma(z)]} \right\} - K(z) \frac{\beta(z)}{\rho(z)} \times \\
 & \times \frac{\partial}{\partial x} \int_0^t \int_0^g T(x, y, z, \tau) d\tau d\vartheta - \frac{1}{\rho(z)} \frac{\partial^2}{\partial x^2} \int_0^t \int_0^g u_{1x}(x, y, z, \tau) d\tau d\vartheta \left\{ K(z) + \frac{5E(z, C)}{6[1 + \sigma(z)]} \right\} - \\
 & - \frac{1}{\rho(z)} \left\{ K(z) - \frac{E(z, C)}{3[1 + \sigma(z)]} \right\} \frac{\partial^2}{\partial x \partial y} \int_0^t \int_0^g u_{1y}(x, y, z, \tau) d\tau d\vartheta + K(z) \frac{\partial}{\partial x} \int_0^t \int_0^g T(x, y, z, \tau) d\tau d\vartheta \times \\
 & \times \frac{\beta(z)}{\rho(z)} - \frac{1}{2\rho(z)} \frac{E(z, C)}{1 + \sigma(z)} \left[ \frac{\partial^2}{\partial y^2} \int_0^t \int_0^g u_{1y}(x, y, z, \tau) d\tau d\vartheta + \frac{\partial^2}{\partial z^2} \int_0^t \int_0^g u_{1z}(x, y, z, \tau) d\tau d\vartheta \right] + \\
 & - \frac{1}{\rho(z)} \frac{\partial^2}{\partial x \partial z} \int_0^t \int_0^g u_{1z}(x, y, z, \tau) d\tau d\vartheta \left\{ K(z) + \frac{E(z, C)}{3[1 + \sigma(z)]} \right\} + u_{0x} \\
 u_{2y}(x, y, z, t) & = \frac{1}{2\rho(z)} \frac{E(z, C)}{1 + \sigma(z)} \left[ \frac{\partial^2}{\partial x^2} \int_0^t \int_0^g u_{1x}(x, y, z, \tau) d\tau d\vartheta + \frac{\partial^2}{\partial x \partial y} \int_0^t \int_0^g u_{1x}(x, y, z, \tau) d\tau d\vartheta \right] + \\
 & + \frac{K(z)}{\rho(z)} \frac{\partial^2}{\partial x \partial y} \int_0^t \int_0^g u_{1y}(x, y, z, \tau) d\tau d\vartheta + \frac{1}{\rho(z)} \frac{\partial^2}{\partial y^2} \int_0^t \int_0^g u_{1x}(x, y, z, \tau) d\tau d\vartheta \left\{ \frac{5E(z, C)}{12[1 + \sigma(z)]} + K(z) \right\} +
 \end{aligned}$$

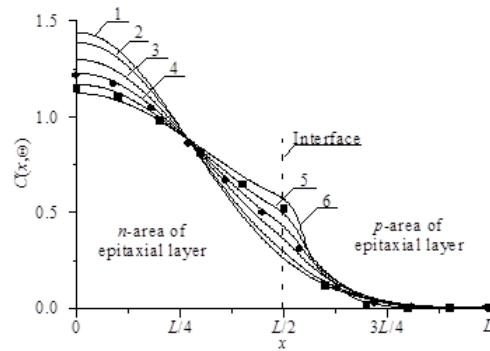
$$\begin{aligned}
 & + \frac{1}{2\rho(z)} \frac{\partial}{\partial z} \left\{ \frac{E(z, C)}{1+\sigma(z)} \left[ \frac{\partial}{\partial z} \int_0^g \int_0^g u_{1y}(x, y, z, \tau) d\tau d\mathcal{G} + \frac{\partial}{\partial y} \int_0^g \int_0^g u_{1z}(x, y, z, \tau) d\tau d\mathcal{G} \right] \right\} - K(z) \frac{\beta(z)}{\rho(z)} \times \\
 & \times \int_0^g \int_0^g T(x, y, z, \tau) d\tau d\mathcal{G} + \frac{1}{\rho(z)} \left\{ K(z) - \frac{E(z, C)}{6[1+\sigma(z)]} \right\} \frac{\partial^2}{\partial y \partial z} \int_0^g \int_0^g u_{1y}(x, y, z, \tau) d\tau d\mathcal{G} - \frac{E(z, C)}{1+\sigma(z)} \times \\
 & \times \frac{1}{2\rho(z)} \left\{ \frac{\partial^2}{\partial x^2} \int_0^g \int_0^g u_{1x}(x, y, z, \tau) d\tau d\mathcal{G} + \frac{\partial^2}{\partial x \partial y} \int_0^g \int_0^g u_{1x}(x, y, z, \tau) d\tau d\mathcal{G} \right\} - \int_0^g \int_0^g T(x, y, z, \tau) d\tau d\mathcal{G} \times \\
 & \times K(z) \frac{\beta(z)}{\rho(z)} - \frac{K(z)}{\rho(z)} \frac{\partial^2}{\partial x \partial y} \int_0^g \int_0^g u_{1y}(x, y, z, \tau) d\tau d\mathcal{G} - \frac{1}{\rho(z)} \frac{\partial^2}{\partial y^2} \int_0^g \int_0^g u_{1x}(x, y, z, \tau) d\tau d\mathcal{G} \left\{ K(z) + \right. \\
 & \left. + \frac{5E(z, C)}{12[1+\sigma(z)]} \right\} - \frac{1}{2\rho(z)} \frac{\partial}{\partial z} \left\{ \frac{E(z, C)}{1+\sigma(z)} \left[ \frac{\partial}{\partial z} \int_0^g \int_0^g u_{1y}(x, y, z, \tau) d\tau d\mathcal{G} + \frac{\partial}{\partial y} \int_0^g \int_0^g u_{1z}(x, y, z, \tau) d\tau d\mathcal{G} \right] \right\} - \\
 & - \frac{1}{\rho(z)} \left\{ K(z) - \frac{E(z, C)}{6[1+\sigma(z)]} \right\} \frac{\partial^2}{\partial y \partial z} \int_0^g \int_0^g u_{1y}(x, y, z, \tau) d\tau d\mathcal{G} + u_{0y} \\
 & \frac{\partial^2 u_{2z}(x, y, z, t)}{\partial t^2} = \frac{1}{2\rho(z)} \frac{E(z, C)}{1+\sigma(z)} \left[ \frac{\partial^2}{\partial x^2} \int_0^g \int_0^g u_{1z}(x, y, z, \tau) d\tau d\mathcal{G} + \frac{\partial^2}{\partial y^2} \int_0^g \int_0^g u_{1z}(x, y, z, \tau) d\tau d\mathcal{G} + \right. \\
 & \left. + \frac{\partial^2}{\partial x \partial z} \int_0^g \int_0^g u_{1x}(x, y, z, \tau) d\tau d\mathcal{G} + \frac{\partial^2}{\partial y \partial z} \int_0^g \int_0^g u_{1y}(x, y, z, \tau) d\tau d\mathcal{G} \right] + \frac{\partial}{\partial z} \left\{ \left[ \frac{\partial}{\partial x} \int_0^g \int_0^g u_{1x}(x, y, z, \tau) d\tau d\mathcal{G} + \right. \right. \\
 & \left. \left. + \frac{\partial}{\partial y} \int_0^g \int_0^g u_{1x}(x, y, z, \tau) d\tau d\mathcal{G} + \frac{\partial}{\partial z} \int_0^g \int_0^g u_{1x}(x, y, z, \tau) d\tau d\mathcal{G} \right] K(z) \right\} \frac{1}{\rho(z)} + \frac{1}{6\rho(z)} \frac{\partial}{\partial z} \left\{ \frac{E(z, C)}{1+\sigma(z)} \times \right. \\
 & \left[ 6 \frac{\partial}{\partial z} \int_0^g \int_0^g u_{1z}(x, y, z, \tau) d\tau d\mathcal{G} - \frac{\partial}{\partial x} \int_0^g \int_0^g u_{1x}(x, y, z, \tau) d\tau d\mathcal{G} - \frac{\partial}{\partial y} \int_0^g \int_0^g u_{1y}(x, y, z, \tau) d\tau d\mathcal{G} - \right. \\
 & \left. - \frac{\partial}{\partial z} \int_0^g \int_0^g u_{1z}(x, y, z, \tau) d\tau d\mathcal{G} \right] \left\} - K(z) \frac{\beta(z)}{\rho(z)} \frac{\partial}{\partial z} \int_0^g \int_0^g T(x, y, z, \tau) d\tau d\mathcal{G} + u_{0z}
 \end{aligned}$$

In this paper we determine concentration of dopant, concentrations of radiation defects and components of displacement vector by using the second-order approximations, which were calculated by using method of averaging of function corrections. This approximation is usually good enough approximation to carry out a qualitative analysis and to obtain some quantitative results. Everything obtained analytical results have been checked by comparison with results of numerical simulations. In this paper, we used explicit difference scheme to solve Eqs. (1), (3) and (5).

### Discussion

In this section we analyzed dynamics of redistributions of dopant and radiation defects under the influence of mismatch-induced stress during annealing. Typical distributions of concentrations of dopant in heterostructure are

presented on FIG. 2 and 3 for diffusion and ion types of doping, respectively. These distributions have been calculated for the case, when the value of dopant diffusion coefficient in doped area is larger, than in nearest areas. The figures show, that inhomogeneity of heterostructure gives us a possibility to increase compactness of distribution of concentration of dopant. At the same time one can find increasing homogeneity of dopant distribution in the doped part of epitaxial layer. The effect leads to decreasing local heating of materials during functioning of transistor or decreasing the dimensions of the transistor for fixed maximal value of local overheat. However, applications of this approach of manufacturing of transistor required optimization annealing of dopant and/or radiation defects. The main reason for this optimization is following. If the annealing time is small, the dopant does not achieve any interfaces between the materials of heterostructure. In this situation one cannot find any modifications of the distribution of concentration of dopant. If the annealing time is large, the distribution of concentration of dopant is too homogenous. We optimize the annealing time based on a recently introduced approach [18-26]. By applying this criterion, the criterion, we approximate real distribution of concentration of dopant by a step wise function FIG. 4 and 5. Next we determine optimal values of annealing time by minimization of the following mean-squared error



**FIG. 2. Distributions of concentration of infused dopant in heterostructure from Fig. 1 in direction, which is perpendicular to interface between epitaxial layer substrate. The increasing number in the curve corresponds to an increase in difference between values of dopant diffusion co-efficient in layers of heterostructure under condition, when the value of dopant diffusion coefficient in epitaxial layer is larger, than value of dopant diffusion coefficient in substrate ( $D_1/D_0=1, D_1/D_0=1.2, D_1/D_0=1.4, D_1/D_0=1.6, D_1/D_0=1.8, D_1/D_0=1.999, D_1/D_0=D_0/D_2$ , respectively;  $\Theta=0.01$  ( $L_x^2+L_y^2+L_z^2)/D_0$ ; average value of dopant diffusion coefficient is equal to  $D_0=1$ ;  $D_1$  and  $D_2$  are values of dopant diffusion co-efficient in doped material of heterostructure and in nearest material). Squares are the experimental data from [27]. Circles are the experimental data from [28]. Both experimental data have been obtained for heterostructure.**

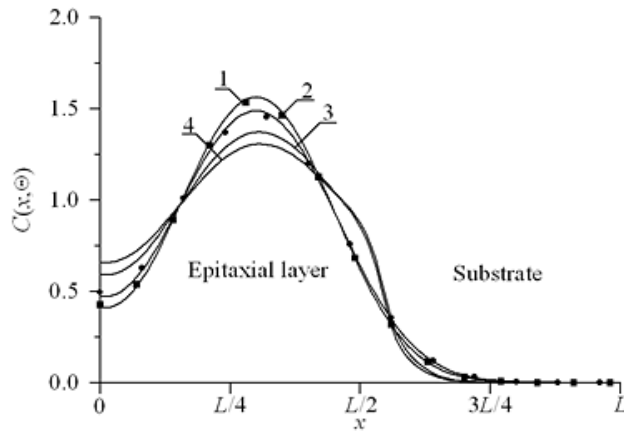


FIG. 3. Distributions of concentration of implanted dopant in heterostructure from Fig. 1. in direction, which is perpendicular to the interface between epitaxial layer substrate. Curves 1 and 3 correspond to annealing time  $\Theta = 0.0048 (L_x^2 + L_y^2 + L_z^2)/D_0$ . Curves 2 and 4 correspond to annealing time  $\Theta = 0.0057 (L_x^2 + L_y^2 + L_z^2)/D_0$ . Curves 1 and 2 correspond to homogenous sample ( $D_1/D_0 = D_0/D_2 = 1$ ). Curves 3 and 4 correspond to heterostructure under condition, when value of dopant diffusion coefficient in epitaxial layer is larger, than value of dopant diffusion coefficient in substrate ( $D_1/D_0 = D_0/D_2 = 1.2$ ). Squares are the experimental data from [29]. Circles are the experimental data from [30]. Both experimental data have been obtained for homogenous samples.

$$U = \frac{1}{L_x L_y L_z} \int_0^{L_x} \int_0^{L_y} \int_0^{L_z} [C(x, y, z, t) - \psi(x, y, z)] dz dy dx \tag{15}$$

Where  $\psi(x, y, z)$  is the step-wise approximation of spatial distribution of concentration of dopant  $C(x, y, z, t)$ . We minimize the mean-squared error as the function of time. After the minimization, we obtain optimal value of annealing time  $\Theta$ . Dependences of optimal values of annealing time on parameters are presented in FIG. 6 and 7. for diffusion and ion types of doping, respectively. It should be noted, that it is necessary to anneal radiation defects after ion implantation. One could find spreading of concentration of the distribution of concentration of dopant during this annealing. In the ideal case distribution of do-pant achieves appropriate interfaces between materials of heterostructure during annealing of radiation defects. If dopant does not achieve to the nearest interface during annealing of radiation defects, it is practical to additionally anneal the dopant. In this situation, the optimal value of the additional annealing time of implanted dopant is smaller, than the annealing time of infused dopant.

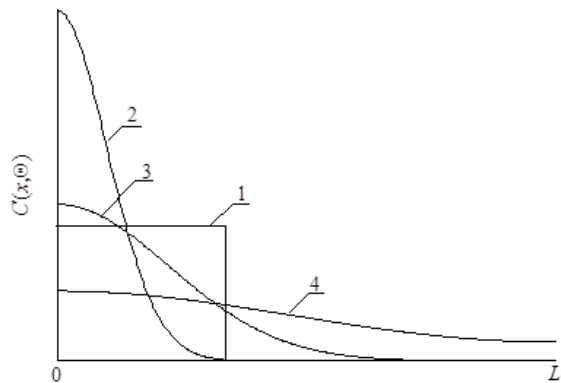


FIG. 4. Spatial distributions of dopant in heterostructure after dopant infusion. Curve 1 is an idealized distribution of

dopant. Curves 2-4 are real distributions of dopant for different values of annealing time. The increasing number in the curve corresponds to the increasing annealing time.

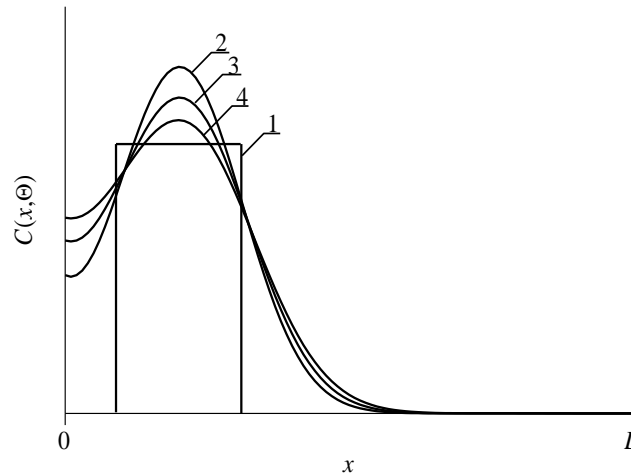


FIG. 5. Spatial distributions of dopant in heterostructure after ion implantation. Curve 1 is an idealized distribution of dopant. Curves 2-4 are real distributions of dopant for different values of annealing time. The increasing number in the curve corresponds to the increasing annealing time.

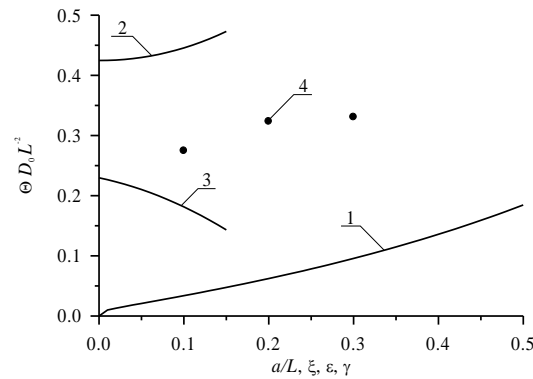


FIG. 6. Dependences of dimensionless optimal annealing time for doping by diffusion, which have been obtained minimization of mean-squared error, on several parameters. Curve 1 is the dependence of dimensionless optimal annealing time on the relation  $a/L$  and  $\xi = \gamma = 0$  for equal values of dopant diffusion coefficient in all parts of heterostructure. Curve 2 is the dependence of dimensionless optimal annealing time on the value of the parameter  $\epsilon$  for  $a/L=1/2$  and  $\xi = \gamma = 0$ . Curve 3 is the dependence of dimensionless optimal annealing time on the value of parameter  $\xi$  for  $a/L= 1/2$  and  $\epsilon = \gamma = 0$ . Curve 4 is the dependence of dimensionless optimal annealing time on value of parameter  $\gamma$  for  $a/L= 1/2$  and  $\epsilon = \xi = 0$ .

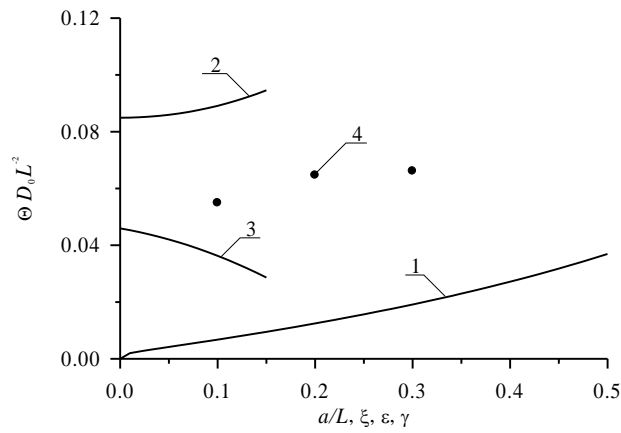


FIG. 7. Dependences of dimensionless optimal annealing time for doping by ion implantation, which have been obtained by minimization of mean-squared error, on several parameters. Curve 1 is the dependence of dimensionless optimal annealing time on the relation  $a/L$  and  $\xi = \gamma = 0$  for equal values of dopant diffusion coefficient in all parts of heterostructure. Curve 2 is the dependence of dimensionless optimal annealing time on the value of the parameter  $\epsilon$  for  $a/L=1/2$  and  $\xi = \gamma = 0$ . Curve 3 is the dependence of dimensionless optimal annealing time on the value of parameter  $\xi$  for  $a/L= 1/2$  and  $\epsilon = \gamma = 0$ . Curve 4 is the dependence of dimensionless optimal annealing time on value of parameter  $\gamma$  for  $a/L=1/2$  and  $\epsilon = \xi = 0$

Next we analyzed the influence of relaxation of mechanical stress on distribution of dopant in doped areas of heterostructure. Under following condition  $\epsilon < 0$  one can find compression of distribution of concentration of dopant near the interface between materials of heterostructure. Contrary (at  $\epsilon > 0$ ) one can find spreading of distribution of concentration of dopant in this area. Accounting relaxation of mismatch-induced stress in heterostructure could leads to changing of optimal values of annealing time.

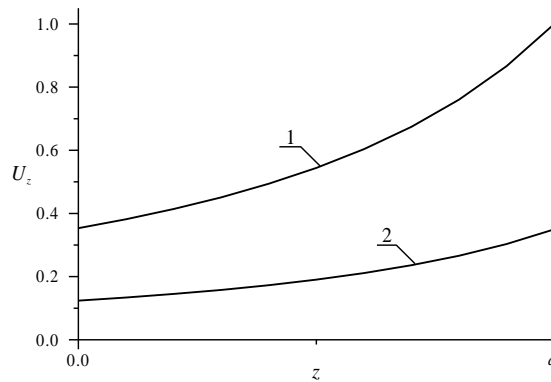


FIG. 8. Normalized dependences of perpendicular to interface between materials of heterostructure components of displacement vector  $u_z$  on coordinate. Curve 1 corresponds to diffusive type of doping. Curve 2 corresponds to ion type of doping.

Farther we compare relaxation of mismatch-induced stress for diffusion and ion types of doping. The Fig. 8 shows dependences of component of displacement vector, which is perpendicular to interface between materials of heterostructure,

on coordinate. Curve 1 corresponds to diffusive type of doping. Curve 2 corresponds to ion type of doping. Reason of decreasing of mismatch-induced stress is radiation processing of materials during ion implantation [26].

## Conclusion

In this paper, we consider a possibility to increase density of elements in circuits NAND and AND. The circuits manufactured based on field-effect hetero transistors. As an accompanying effect, we consider an approach to decrease mismatch-induced stress.

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